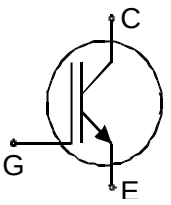
SIGC156T60SNR2C

IGBT Chip in NPT-technology

FEATURES:
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

This chip is used for:
- IGBT-Modules

Applications:
- drives



Chip Type	V_{CE}	I_{Cn}	Die Size	Package	Ordering Code
SIGC156T60SNR2C	600V	200A	12.5 x 12.5 mm^2	sawn on foil	Q67050-A4154-A003

MECHANICAL PARAMETER:

Raster size	12.5 x 12.5	mm^2
Area total / active	156.25 / 138.2	
Emitter pad size	8x(2.58x4.78)	
Gate pad size	0.8 x 1.46	
Thickness	100	µm
Wafer size	150	mm
Flat position	90	deg
Max.possible chips per wafer	84	
Passivation frontside	Photoimide	
Emitter metallization	3200 nm Al Si 1%	
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding	
Die bond	electrically conductive glue or solder	
Wire bond	Al, ≤500µm	
Reject Ink Dot Size	∅ 0.65mm ; max 1.2mm	
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C	

SIGC156T60SNR2C

MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T_j=25 °C	V_{CE}	600	V
DC collector current, limited by T_{jmax}	I_C	1)	A
Pulsed collector current, t_p limited by T_{jmax}	I_{cpuls}	600	A
Gate emitter voltage	V_{GE}	±20	V
Operating junction and storage temperature	T_j, T_{stg}	-55 ... +150	°C

1) depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j=25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE}=0V, I_C=5mA	600			V
Collector-emitter saturation voltage	$V_{CE(sat)}$	V_{GE}=15V, I_C=200A	1.6	2	2.5	
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C=4mA, V_{GE}=V_{CE}	3	4	5	
Zero gate voltage collector current	I_{CES}	V_{CE}=600V, V_{GE}=0V			13.5	µA
Gate-emitter leakage current	I_{GES}	V_{CE}=0V, V_{GE}=20V			600	nA
Integrated gate resistor	R_{Gint}			5		Ω

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	V_{CE}=25V	-	10330	12400	pF
Output capacitance	C_{oss}	V_{GE}=0V	-	970	1160	
Reverse transfer capacitance	C_{rss}	f=1MHz	-	594	710	

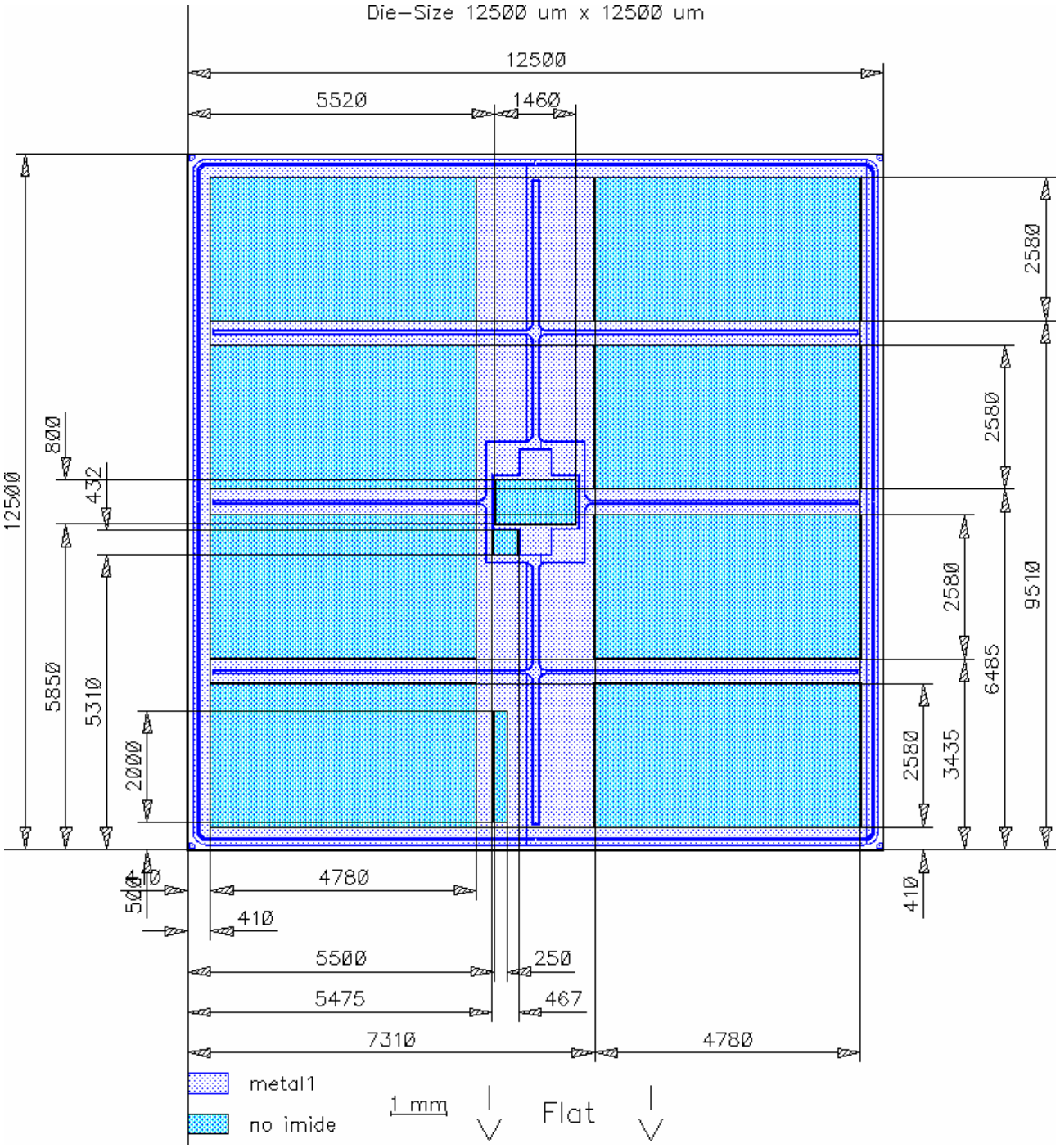
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 2)	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T_j=150°C V_{CC}=400V I_C=200A V_{GE}=+15/0V R_G=1.7Ω	-	70	98	ns
Rise time	t_r		-	60	84	
Turn-off delay time	$t_{d(off)}$		-	500	700	
Fall time	t_f		-	100	140	

2) switching conditions different to 600V Standard IGBT 2, under comparable switching conditions 40% faster turnoff than Standard IGBT 2. Values also influenced by parasitic L- and C- in measurement and package.

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CHIP DRAWING:



SIGC156T60SNR2C

FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the
device data sheet

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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